Electronic Supporting Information for

# Crystal Phase of Nickel Sulfides Dictates Hydrogen Evolution Activity

## of Various Semiconducting Photocatalysts

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### Material characterization

The crystal phase was performed by X-ray diffraction (XRD) on a Bruker D8 Advanced X-ray Diffractometer (Cu-K $\alpha$  radiation:  $\lambda = 0.15406$  nm). The microstructures and morphology of samples were observed by field emission scanning electron microscopy (FE-SEM, S-4800II) under the acceleration voltage of 5.0 kV. High-resolution TEM (HRTEM) images and elemental mapping were captured on a Tecnai G2 F30 S-TWIN at an acceleration voltage of 300 kV. The light absorption capacity was tested by Cary 5000 UV-visible-near-infrared absorption spectrometer. X-ray photoelectron spectra (XPS) was obtained on a Thermo Scientific ESCALAB 250 apparatus. The photoluminescence (PL) spectra were obtained by Edinburgh FLS1000 fluorescence spectrometer.

### **Photo-electrochemical test**

The photocurrents were measured by a CHI 660E electrochemical system, which was equipped with a standard three-electrode system. 2 mg of samples was dispersed in a solution containing 85  $\mu$ L ethanol and 15  $\mu$ L EG. Then 30  $\mu$ L of the suspension was drop-casted onto an indiumtin oxide (ITO)-coated glass and dried on a 1 cm\*1 cm area. In the experiment, an ITO with a sample on it was used as a working electrode. Pt wire was employed as the counter electrode and the reference electrode was Ag/AgCl/sat. KCl. A bias potential of -0.1V (vs. Ag/AgCl) was employed. Na<sub>2</sub>SO<sub>4</sub> solution (0.1 M) was used as the electrolyte. The light source was a 300 W Xe lamp. The Mott-Schottky plots were also measured using the same three electrode system over an alternating current frequency of 1500 Hz in 0.1M Na<sub>2</sub>SO<sub>4</sub> aqueous solution.

#### **Theoretical simulation**

The DFT calculations were carried out using the Vienna ab initio simulation package (VASP). The exchange-correlation energy was described using the (PBE). The Perdew-Burke-Ernzerhof (PBE) functional combined with Projected Augmented Wave (PAW) pseudopotentials was used. A 520 eV plane-wave kinetic energy cut off was selected, and a  $3 \times 3 \times 1$  Monhorst-Pack *k* point sampling was adopted for the structure relaxation. A p(2×2) supercell model with 15 Å vaccum in c-axis was employed to simulate the NiS<sub>x</sub>. A residual force threshold of 0.05 eV Å<sup>-1</sup> was set for geometry optimizations. The calculated surface in (001) surface in model building process.

The Gibbs free-energy ( $\Delta G_{H^*}$ ) is expressed as:  $\Delta G_{H^*} = \Delta E_{H^*} + \Delta E_{ZPE} - T\Delta S$ . Where  $\Delta E_{H^*}$ ,  $\Delta E_{ZPE}$ and  $\Delta S$  are the adsorption energy of atomic hydrogen on the given surface, zero point energy correction and entropy change of H\* adsorption, respectively. The zero point energy correction can be estimated by the equation  $\Delta E_{ZPE} = E_{ZPE}(H^*) - 1/2E_{ZPE}(H_2)$ .  $\Delta S$  can be calculated by the equation  $\Delta S = S(H^*) - 1/2S(H_2) \approx -1/2S(H_2)$ , due to the negligible of the entropy of hydrogen in adsorbed state.  $\Delta E_{H^*}$  is calculated as  $\Delta E_{H^*} = E_{tot} - E_{sub} - 1/2EH_2$ , where  $E_{tot}$  and  $E_{sub}$  are energies of H absorbed system and the clean given surface, and  $EH_2$  is the energy of H<sub>2</sub> molecular in gas phase.

### Electrocatalytic hydrogen evolution measurement

The electrocatalytic hydrogen evolution performance of NiS<sub>x</sub> was evaluated on a CHI660E electrochemical workstation. Electrochemical analysis was performed using a standard three-electrode system, which contains a working electrode (a glassy carbon electrode loaded with 0.21 mg/cm<sup>2</sup> catalysts), a reference electrode (a Hg/HgO electrode) and a counter electrode (a Pt wire). 0.5 M H<sub>2</sub>SO<sub>4</sub> was applied as electrolyte. An electrochemical activation process was firstly scanned in cyclic voltammetry from 0 to 0.9 V (vs. Hg/HgO) for 5 circles. Then, the linear sweep voltammetry (LSV) for HER was acquired at the scan rate of 5 mV s<sup>-1</sup>. Finally, all measured potentials are converted to reversible hydrogen electrode (RHE) potentials according to the Nernst equation ( $E_{(RHE)}=E_{(Hg/HgO)} + 0.098V + 0.059 \times pH$ ).

Sample	Crystal Phase	Space Group	a (nm)	c (nm)	V (nm³)
h-NiS	hexagonal	P6 <sub>3</sub> /mmc	0.342	0.528	0.0267
t-NiS	trigonal	R3m	0.963	0.315	0.126
c-NiS <sub>2</sub>	cubic	Pa∃	0.567		0.182

Table S1. The phase structure and crystal cell parameters of  $NiS_x$ .

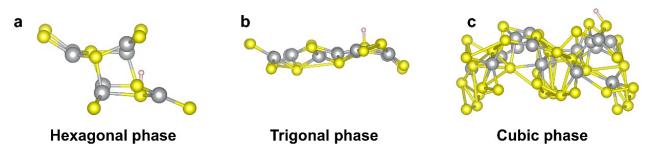


Figure S1. Optimized atomic structures of phase-engineered  $NiS_x$  adsorbed with H atom.

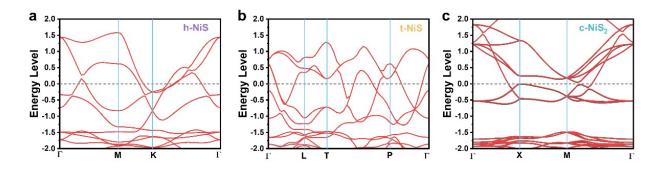


Figure S2. Calculated band structures of h-NiS, t-NiS and c-NiS<sub>2</sub>.

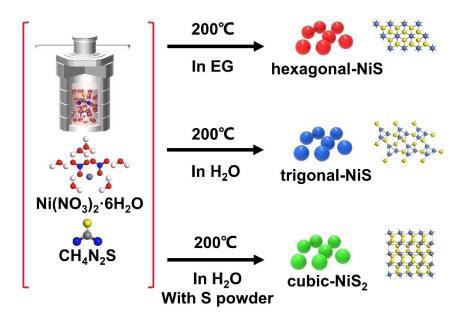


Figure S3. Synthetic processes of phase-engineered  $NiS_x$ .

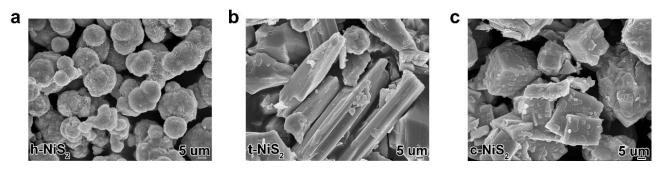


Figure S4. SEM images of h-NiS, t-NiS and c-NiS<sub>2</sub>.

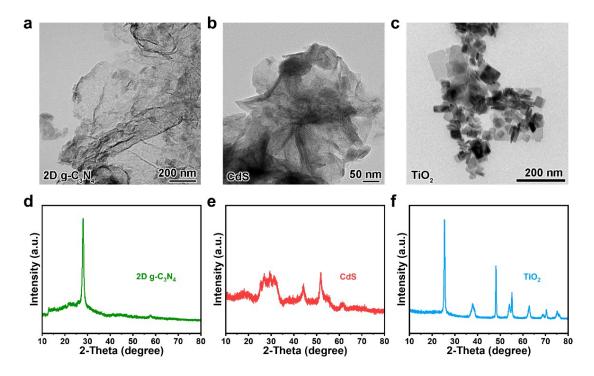


Figure S5. (a-c) TEM images of CN nanosheets, CdS nanosheets and TiO<sub>2</sub> nanosheets. (d-f) XRD patterns of CN nanosheets, CdS nanosheets and TiO<sub>2</sub> nanosheets.

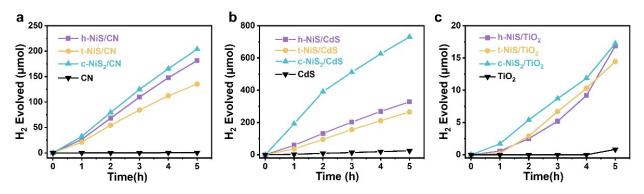


Figure S6. Time-dependent hydrogen evolution performance of the catalysts.

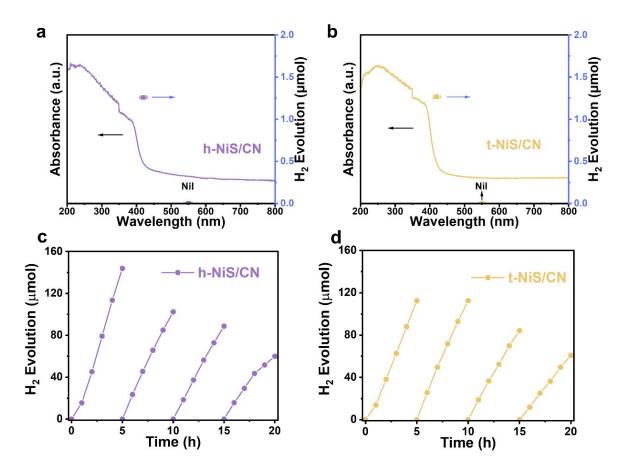


Figure S7. (a-b) Wavelength-dependent hydrogen evolution performance of h-NiS/CN and t-NiS/CN. (c-d) Catalytic stability tests of h-NiS/CN and t-NiS/CN.

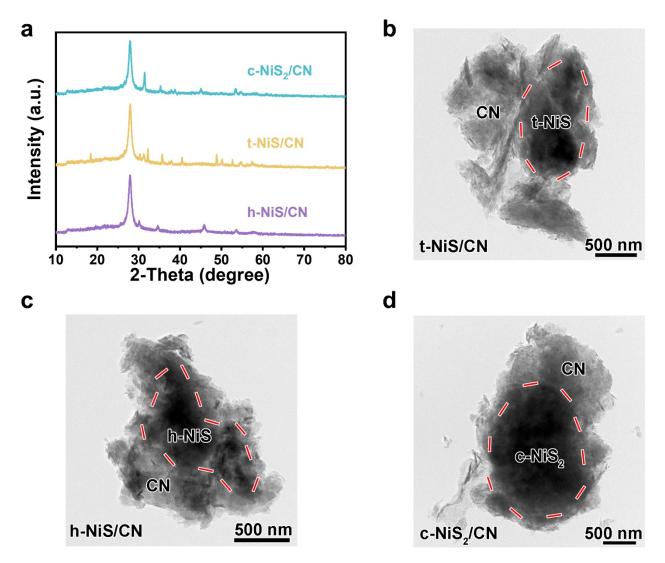


Figure S8. (a) XRD patterns and (b-c) TEM images of h-NiS/CN, t-NiS/CN and c-NiS $_2$ /CN

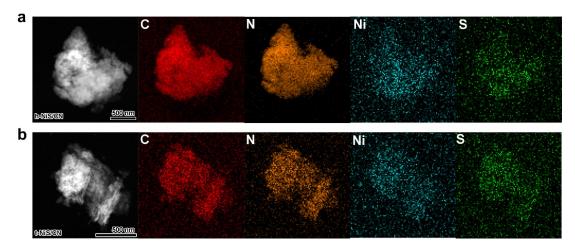


Figure S9. STEM images of corresponding elemental mapping of (a) h-NiS/CN and (b) t-NiS/CN

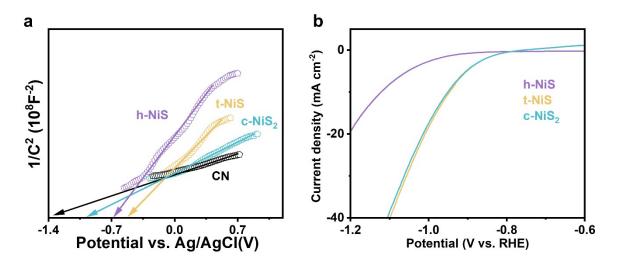


Figure S10. (a) Mot-schottky curves of h-NiS, t-NiS, c-NiS<sub>2</sub> and CN in 0.5 M Na<sub>2</sub>SO<sub>4</sub>. (b) LSV curves of h-NiS, t-NiS and c-NiS<sub>2</sub> in 0.5 M H<sub>2</sub>SO<sub>4</sub>.

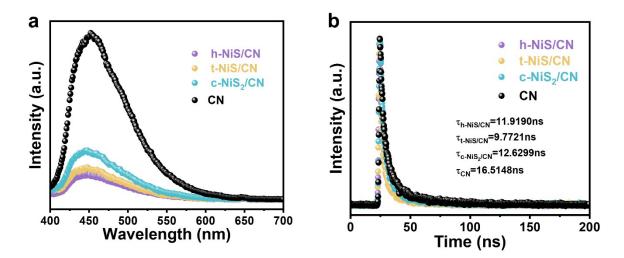


Figure S11. (a) Steady-state and (b) transient-state fluorescence spectra of CN, h-NiS/CN, t-NiS/CN and c-NiS<sub>2</sub>/CN.

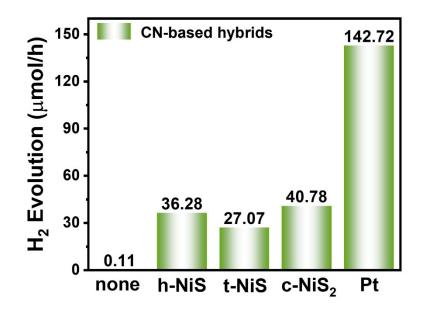


Figure S12. performance comparison between Pt and phase-engineered  $NiS_x$  using CN as hosting semiconductor.